## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | YANAGAWA ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-2003/0227253	12-2003	Seo et al.	313/504
	В	US-2002/0047568	04-2002	Koyama, Jun	315/169.3
*	С	US-2001/0045558	11-2001	Kawasaki et al.	257/66
*	D	US-6,528,951	03-2003	Yamazaki et al.	315/169.3
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	·				
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## **NON-PATENT DOCUMENTS**

* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	x			

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